

# 30V, N-Channel NexFET™ Power MOSFETs

## 1 Features

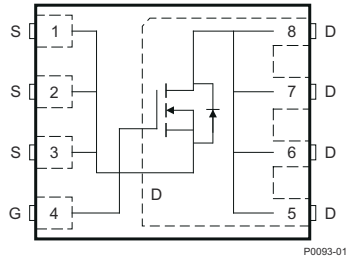
- Ultralow  $Q_g$  and  $Q_{gd}$
- Low thermal resistance
- Avalanche rated
- Pb free terminal plating
- RoHS compliant
- Halogen Free
- SON 5mm × 6mm plastic package

## 2 Applications

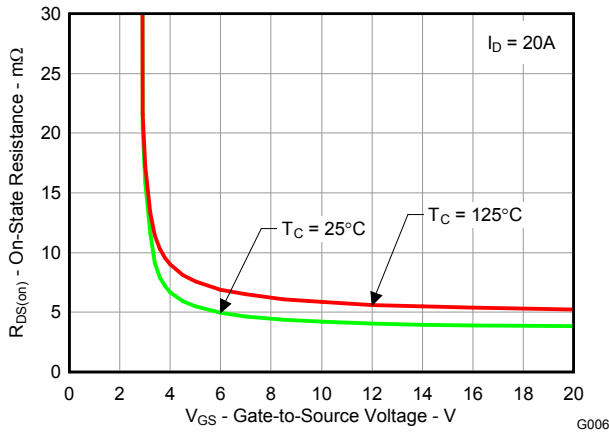
- Point-of-load synchronous buck in networking, telecom, and computing systems
- Optimized for control and synchronous FET applications

## 3 Description

The NexFET™ power MOSFET has been designed to minimize losses in power conversion applications.



Top View



$R_{DS(on)}$  vs  $V_{GS}$

## Product Summary

$V_{DS}$	Drain to Source Voltage	30	V
$Q_g$	Gate Charge Total (4.5V)	6.4	nC
$Q_{gd}$	Gate Charge Gate to Drain	1.9	nC
$R_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = 4.5V$	5.4 mΩ
		$V_{GS} = 10V$	4.1 mΩ
$V_{GS(th)}$	Threshold Voltage	1.5	V

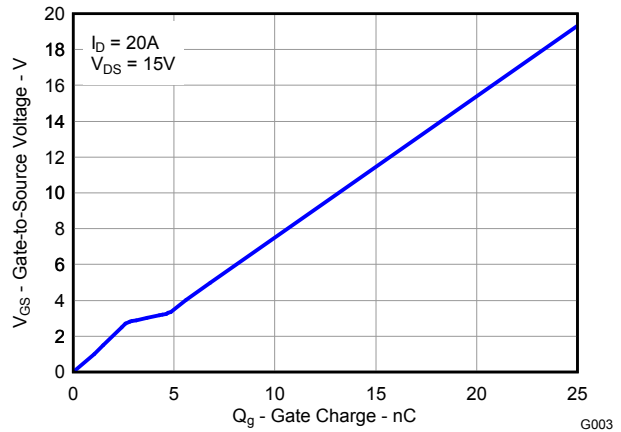
## Ordering Information

Device	Package	Media	Qty	Ship
CSD17510Q5A	SON 5mm × 6mm Plastic Package	13-Inch Reel	2500	Tape and Reel

## Absolute Maximum Ratings

$T_A = 25^\circ C$ unless otherwise stated		VALUE	UNIT
$V_{DS}$	Drain to Source Voltage	30	V
$V_{GS}$	Gate to Source Voltage	±20	V
$I_D$	Continuous Drain Current, $T_C = 25^\circ C$	55	A
	Continuous Drain Current <sup>(1)</sup>	20	A
$I_{DM}$	Pulsed Drain Current, $T_A = 25^\circ C$ <sup>(2)</sup>	129	A
$P_D$	Power Dissipation <sup>(1)</sup>	3	W
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 to 150	°C
$E_{AS}$	Avalanche Energy, single pulse $I_D = 54A, L = 0.1mH, R_G = 25\Omega$	146	mJ

- (1) Typical  $R_{\theta JA} = 41^\circ C/W$  on 1-inch<sup>2</sup> (6.45cm<sup>2</sup>), 2oz. (0.071mm thick) Cu pad on a 0.06-inch (1.52mm) thick FR4 PCB.
- (2) Pulse duration  $\leq 300\mu s$ , duty cycle  $\leq 2\%$



GATE CHARGE



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## 4 Electrical Characteristics

(T<sub>A</sub> = 25°C unless otherwise stated)

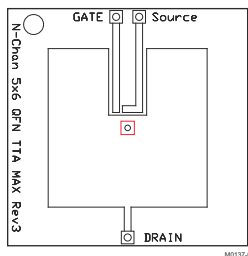
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>Static Characteristics</b>						
BV <sub>DSS</sub>	Drain to Source Voltage	V <sub>GS</sub> = 0V, I <sub>DS</sub> = 250µA	30			V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 24V			1	µA
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 20V			100	nA
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 250µA	1	1.5	2.1	V
R <sub>DS(on)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 4.5V, I <sub>DS</sub> = 20A		5.4	7.3	mΩ
		V <sub>GS</sub> = 10V, I <sub>DS</sub> = 20A		4.1	5.2	mΩ
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 15V, I <sub>DS</sub> = 20A		59		S
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 15V, f = 1MHz		960	1250	pF
C <sub>oss</sub>	Output Capacitance			630	820	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			51	66	pF
R <sub>G</sub>	Series Gate Resistance			0.85	1.7	Ω
Q <sub>g</sub>	Gate Charge Total (4.5V)	V <sub>DS</sub> = 15V, I <sub>DS</sub> = 20A		6.4	8.3	nC
Q <sub>gd</sub>	Gate Charge Gate to Drain			1.9		nC
Q <sub>gs</sub>	Gate Charge Gate to Source			2.7		nC
Q <sub>g(th)</sub>	Gate Charge at V <sub>th</sub>			1.5		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 13.5V, V <sub>GS</sub> = 0V		16		nC
t <sub>d(on)</sub>	Turn On Delay Time	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 4.5V, I <sub>DS</sub> = 20A, R <sub>G</sub> = 2Ω		7		ns
t <sub>r</sub>	Rise Time			11		ns
t <sub>d(off)</sub>	Turn Off Delay Time			9		ns
t <sub>f</sub>	Fall Time			4.1		ns
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 20A, V <sub>GS</sub> = 0V		0.85	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DD</sub> = 13.5V, I <sub>F</sub> = 20A, di/dt = 300A/µs		25		nC
t <sub>rr</sub>	Reverse Recovery Time			24		ns

## 5 Thermal Characteristics

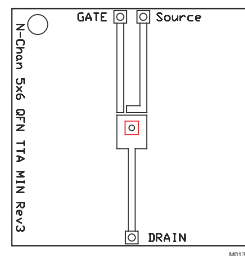
(T<sub>A</sub> = 25°C unless otherwise stated)

PARAMETER		MIN	TYP	MAX	UNIT
R <sub>θJC</sub>	Thermal Resistance Junction to Case <sup>(1)</sup>			1.6	°C/W
R <sub>θJA</sub>	Thermal Resistance Junction to Ambient <sup>(1) (2)</sup>			51	°C/W

- (1) R<sub>θJC</sub> is determined with the device mounted on a 1-inch<sup>2</sup> (6.45cm<sup>2</sup>), 2oz. (0.071mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81cm × 3.81cm), 0.06-inch (1.52mm) thick FR4 PCB. R<sub>θJC</sub> is specified by design, whereas R<sub>θJA</sub> is determined by the user's board design.
- (2) Device mounted on FR4 material with 1-inch<sup>2</sup> (6.45cm<sup>2</sup>), 2oz. (0.071mm thick) Cu.



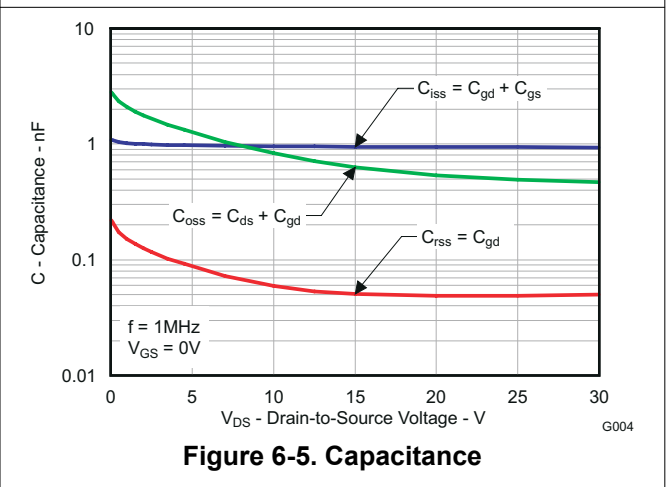
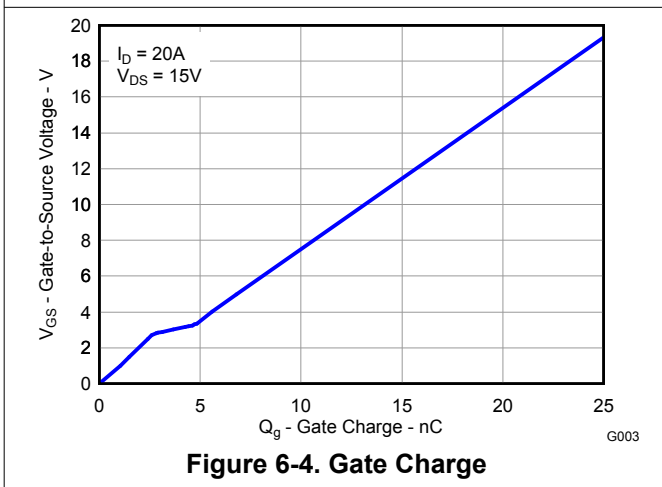
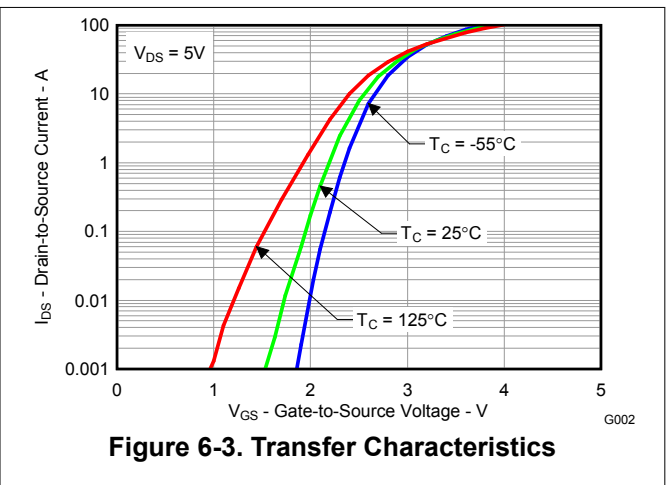
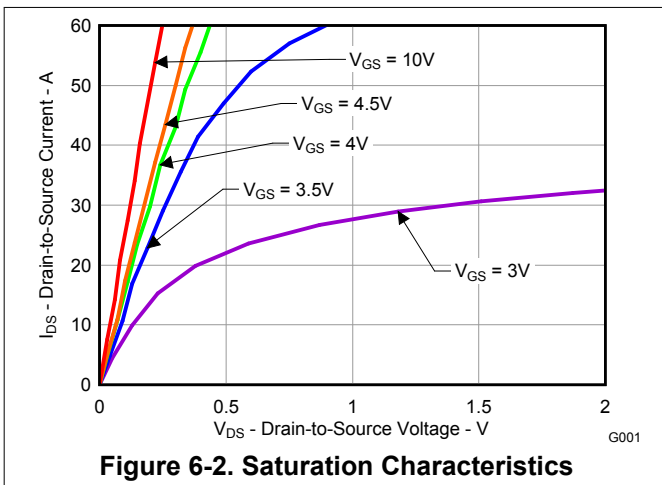
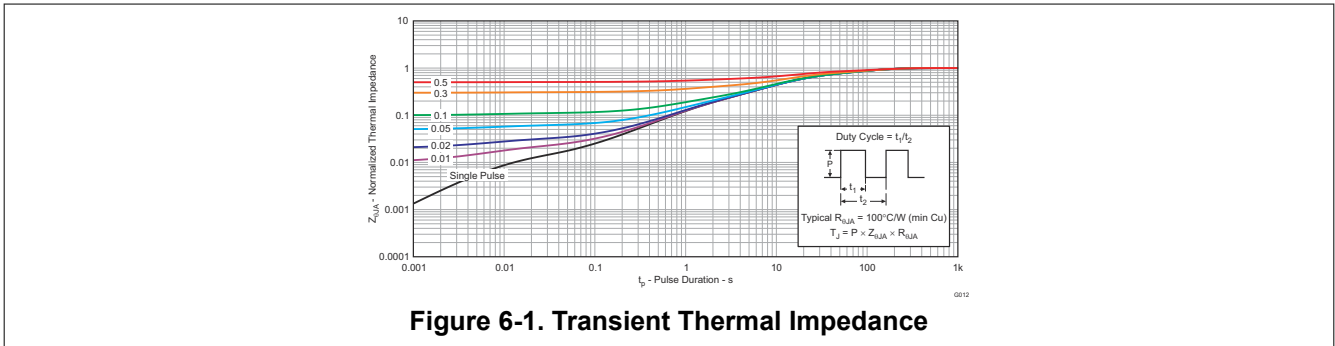
Max R<sub>θJA</sub> = 51°C/W  
when mounted on 1 inch<sup>2</sup>  
(6.45cm<sup>2</sup>) of 2oz. (0.071mm  
thick) Cu.

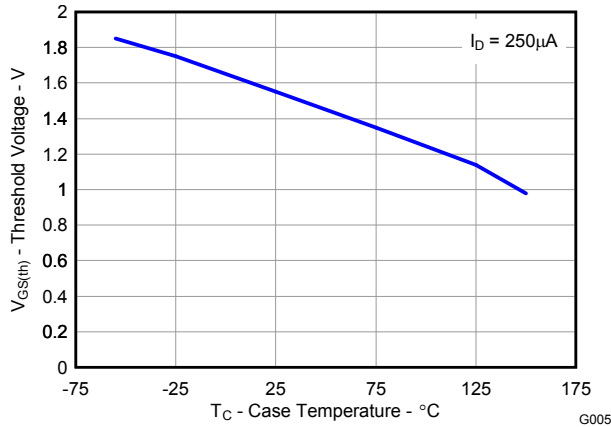


Max R<sub>θJA</sub> = 125°C/W when  
mounted on a minimum pad  
area of 2-oz. (0.071mm  
thick) Cu.

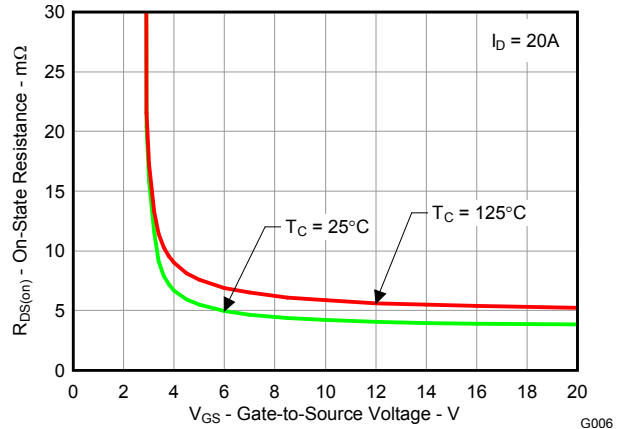
## 6 Typical MOSFET Characteristics

( $T_A = 25^\circ\text{C}$  unless otherwise stated)

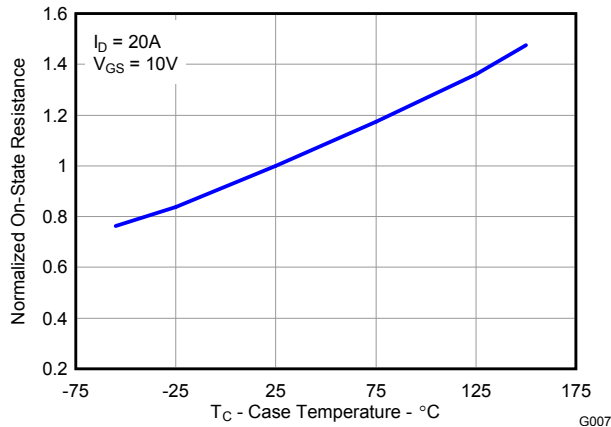




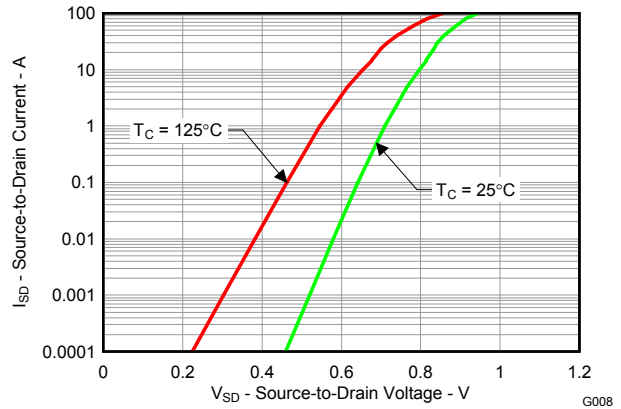
**Figure 6-6. Threshold Voltage vs. Temperature**



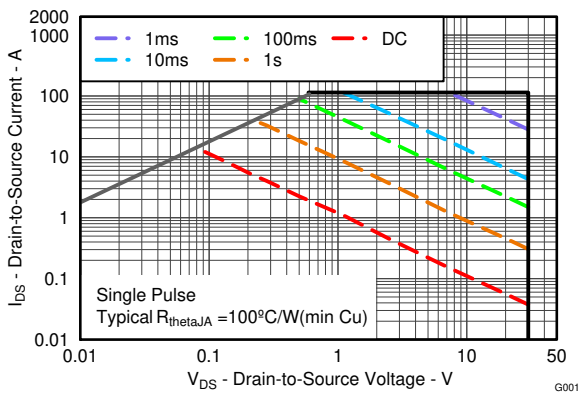
**Figure 6-7. On-State Resistance vs. Gate-to-Source Voltage**



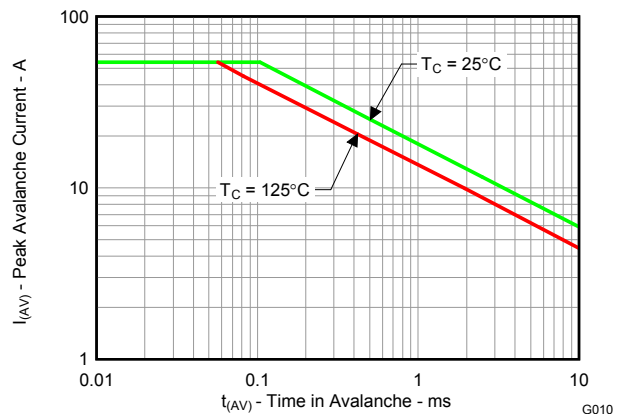
**Figure 6-8. Normalized On-State Resistance vs. Temperature**



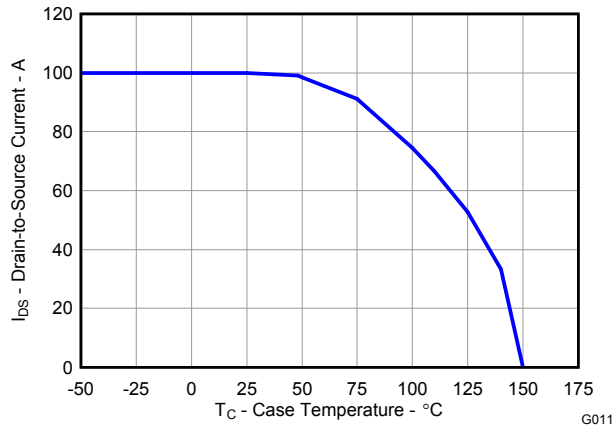
**Figure 6-9. Typical Diode Forward Voltage**



**Figure 6-10. Maximum Safe Operating Area**



**Figure 6-11. Single Pulse Unclamped Inductive Switching**



**Figure 6-12. Maximum Drain Current vs. Temperature**

## 7 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 7.1 Third-Party Products Disclaimer

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### 7.2 Documentation Support

#### 7.2.1 Related Documentation

### 7.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 7.4 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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### 7.5 Trademarks

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All trademarks are the property of their respective owners.

### 7.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 7.7 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 8

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from Revision G (September 2012) to Revision H (December 2024) Page

- Updated the numbering format for tables, figures, and cross-references throughout the document..... 1

### Changes from Revision \* (July 2010) to Revision A ( ) Page

- Changed the Y axis scale for [Figure 6-5](#) ..... 4

Changes from Revision F (October 2011) to Revision G (September 2012)	Page
• Changed <a href="#">Figure 6-10</a> .....	4

Changes from Revision E (July 2011) to Revision F (October 2011)	Page
• Changed the $I_D$ Continuous Drain Current, $T_C = 25^\circ\text{C}$ value From: 100A To: 55A.....	1
• Changed <a href="#">Figure 6-10</a> .....	4

Changes from Revision A (August 2010) to Revision B ( )	Page
• Changed $R_{DS(on)}$ Test Conditions From $V_{GS} = 8\text{V}$ To: $V_{GS} = 10\text{V}$ .....	3

Changes from Revision B (September 2010) to Revision C ( )	Page
• Absolute Maximum Ratings, changed the $E_{AS}$ value from 45 to 146mJ.....	1

Changes from Revision C (September 2010) to Revision D ( )	Page
--	------

Changes from Revision D (November 2010) to Revision E ( )	Page
• Changed $V_{GS}$ in the Abs Max Ratings table From: +20/-12V To: $\pm 20\text{V}$ .....	1
• Changed from +20/-12V to 20V.....	3



## 9 Mechanical Data

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD17510Q5A	ACTIVE	VSONP	DQJ	8	2500	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD17510	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**

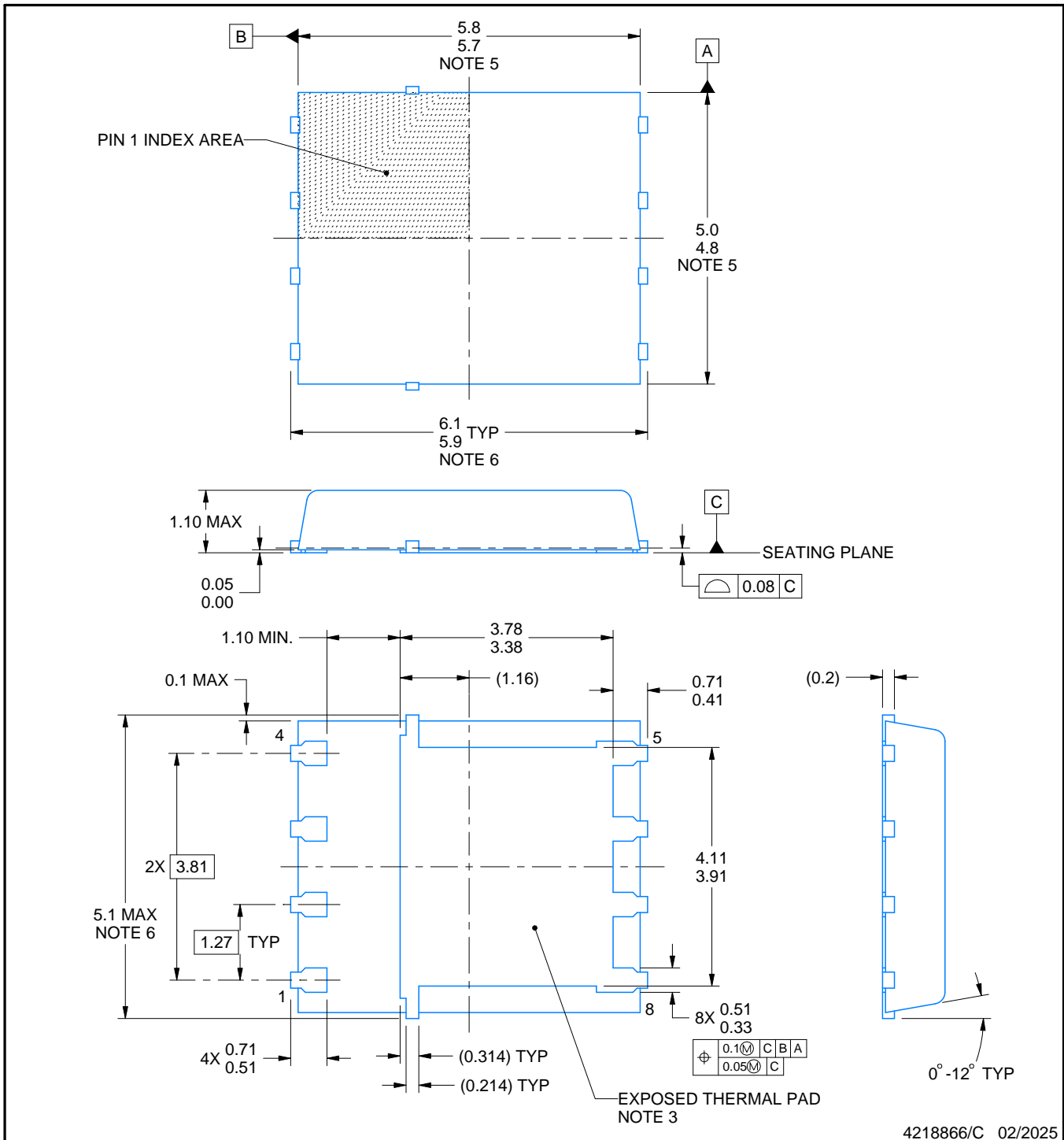
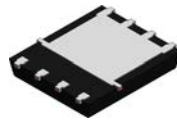

\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD17510Q5A	VSONP	DQJ	8	2500	330.0	12.4	6.3	5.3	1.2	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD17510Q5A	VSONP	DQJ	8	2500	340.0	340.0	38.0



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NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
- Metalized features are supplier options and may not be on the package.
- These dimensions do not include mold flash protrusions or gate burrs.
- These dimensions include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25 mm per side.

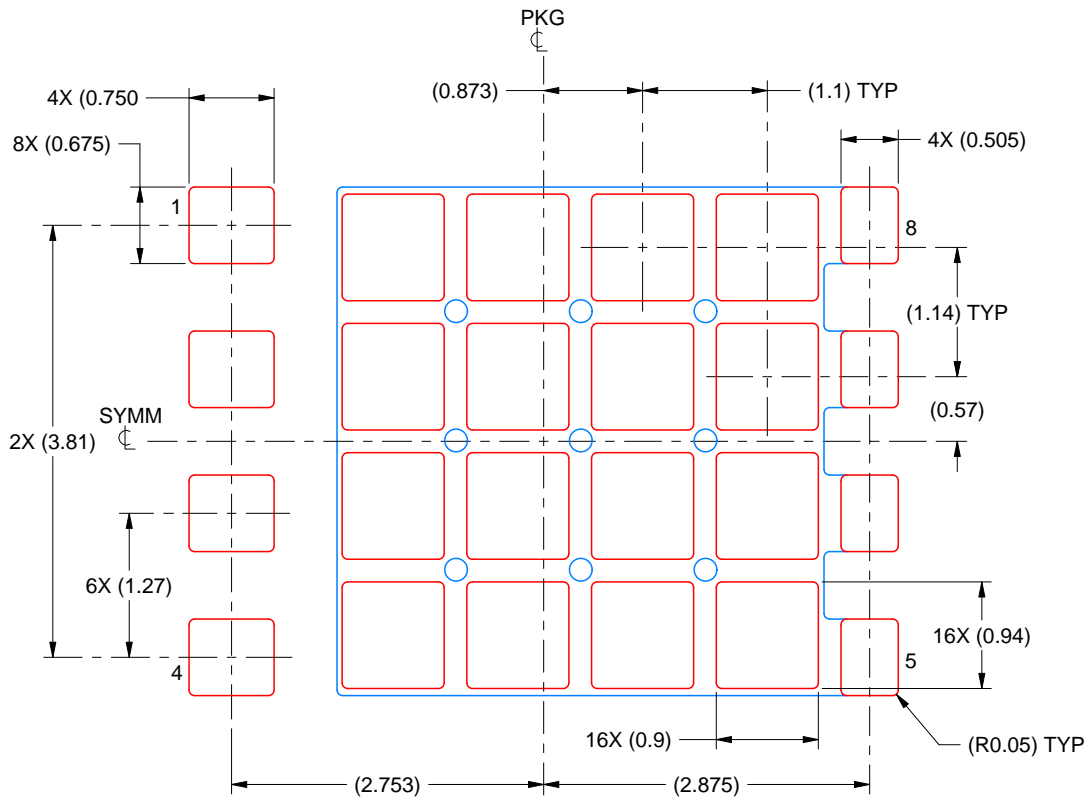


# EXAMPLE STENCIL DESIGN

DQJ0008A

VSONP - 1.1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD:  
70% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE: 15X

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NOTES: (continued)

9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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